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Chi-Sing Ho, Neal Jean, Amr Saleh, Stefano Ermon, Niaz Banaei, Jennifer A. Dionne, "Rapid bacterial identification based on surface-enhanced Raman scattering and machine learning (Conference Presentation) (Withdrawal Notice)," Proc. SPIE 10479, Light-Based Diagnosis and Treatment of Infectious Diseases, 1047904 (10 April 2018); doi: 10.1117/12.2291601

Event: SPIE BiOS, 2018, San Francisco, California, United States
Rapid bacterial identification based on surface-enhanced Raman scattering and machine learning (Conference Presentation)  

(Withdrawal Notice)


Online Publication Date: 14 March 2018  
Withdrawn from Publication: 10 April 2018

Conference Date: 29–31 January 2018
Conference Location: San Francisco, California, United States
Conference Title: Light-Based Diagnosis and Treatment of Infectious Diseases
Conference Chairs: Tianhong Dai

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Publisher's Note: This conference presentation, originally published on 14 March 2018, was withdrawn per author request.